

Notic of References Cited

Application/Control No.

09/788,315

Applicant(s)/Patent Under
Reexamination
YOON ET AL.

Examiner

Hong Liu

Art Unit

1624

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	CAS printout for Teranishi et al. (JP 10077286) 1998.
	V	CAS printout for Hamazaki et al. Chem. Abs. 100: 5477.
	W	
	X	

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